

Assessment of Power Consumption Using a Single Edge Triggering Flip Flop versus a Clocked CMOS Flip Flop

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Keywords: Clocked CMOS Flip Flop, Consumption, Flip Flop, MATLAB, Novel Single Edge Triggering Flip Flop, Power.

Abstract: This study focuses on evaluating the power consumption using a Single Edge Triggering Flip Flop in comparison with a clocked CMOS Flip Flop. The research is divided into two groups, each consisting of 10 samples: Group 1 involves the design of a clocked CMOS Flip Flop, and Group 2 deals with the design of a Novel Single Edge Triggering Flip Flop. The sample size was determined using a G power of 80%. Various length values were employed for the constructed Flip Flops, ranging from 30 nm to 90 nm, utilizing the Gate Diffusion Input (GDI) technique. The outcomes reveal that the Power Consumption of the Single Edge Triggering Flip-Flop is 0.5540 watts, whereas the Power Consumption of the clocked CMOS Flip-Flop is 4.7680 watts. The independent sample t-test, with a significance value of $p=0.000$ ($p<0.05$), indicates statistically significant differences in behaviour between the novel Single Edge Triggering Flip Flop and the clocked CMOS Flip Flop. In conclusion, it is evident that the clocked CMOS Flip Flop consumes more power than the Single Edge Triggering Flip Flop.

1 INTRODUCTION

CMOS logic circuits hold a significant role across a wide spectrum of digital applications, spanning from consumer electronics to industrial control systems. These circuits constitute a fundamental component in modern digital design (Thornton 2014). A Flip Flop featuring a single-edge trigger is a type of digital electrical circuit designed to store and manipulate binary data. It is characterized by its triangular shape and clock input lead. Notably, CMOS devices exhibit high noise immunity and low static power consumption, which are their key attributes. However, due to one of the matched transistors being always off, the arrangement consumes considerable energy during transitions between on and off states (Chang, Dai, and Lin 2023).

Flip Flops find utility in various applications, including counters, memory units, frequency dividers, and latches (Sharma et al. 2009). Clocked-CMOS is a logic family that merges the synchronization introduced by clock signals with the

static logic architecture (Lee and Jang 2012). During its inception, many small-scale integrated (SSI) and medium-scale integrated (MSI) chips were rooted in CMOS technology. Even in contemporary design, this approach remains beneficial for specific applications, such as dynamic "NORA" circuits (Mangawati and Palecha 2019).

In recent years, more than 200 articles have been published, with 89 of them appearing in scientific journals. Some significant articles in the domain of low-power Flip Flop design include "Design and Implementation of Low Power 20 Transistor CMOS SET Flip Flop" by Kang and Leblebici (2002), "Low Power Flip Flop Designs Using Different Logic Styles" by Soudris, Piguat, and Goutis (2002), "A Revolutionary Low-Power, High-Speed, and Resilient TSPC Flip-Flop Design" by Pontikakis (2003), "Low Power Flip Flop Using Double Edge Triggered Techniques" by Dey et al (2022), and "Low Power Flip Flop Using Double Edge Triggered Techniques" by Daroch (2013). These articles contribute significantly to the field of low-power Flip Flop design and technology.

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In summary, the power consumption comparison between a 20-transistor CMOS Double Edge Triggering Flip Flop and a True Single Phase Flip Flop depends on specific design decisions and usage scenarios. Different research findings offer conflicting perspectives, with some suggesting that the Double Edge Triggering flip-flop consumes less power than the True Single-Phase Clocking flip-flop, while others indicate the opposite. In general, it is evident that the Double Edge Triggering flip-flop holds promise as a low-power design option that has the potential to outperform conventional flip-flops in terms of power efficiency.

Clock CMOS flip-flops are renowned for their higher power consumption in comparison to other flip-flop variants. This disparity arises from dynamic power consumption, stemming from the repetitive toggling between high and low states within each clock cycle inherent to clocked CMOS flip-flops. The consistent charging and discharging of capacitors within CMOS circuitry contribute to elevated energy consumption, constituting a limitation for clocked CMOS flip-flops. The current study aims to assess power consumption by juxtaposing Single Edge Triggering Flip Flops against Clocked Flip Flops, utilizing a 20-transistor model CMOS technology.

2 MATERIALS AND METHODS

The research was carried out within the Department of Electronics and Communication Engineering at Saveetha Institute of Medical and Technical Science (SIMATS), Chennai, specifically at Saveetha School of Engineering. The investigation involved the testing of an integrated Flip Flop, with varying lengths subjected to evaluation. These length measurements spanned from 30 nm to 90 nm and were assessed using the Gate Diffusion Input (GDI) technique, as described in the study titled "Area and Power Efficient Design of Edge Triggered D Flip Flop Using GDI Technique" in 2018. The study was divided into two distinct groups: Group 1 consisted of Clocked CMOS Flip Flops, while Group 2 featured Novel Single Edge Triggering Flip Flops. Each group was composed of a sample size of 10 participants. The sample size determination was performed using clincalc.com, incorporating the F Score derived from prior research studies. In the calculation, the preset power remained constant at 80%, while the alpha value was set at 0.05 in accordance with statistical standards (Brown and Vranesic 2005; Simon 2020).

MATLAB played a pivotal role in this study, serving as the primary tool for simulations. Its

utilization was crucial for the development and exploration of engineering projects, products, and systems. By employing MATLAB, the time required for product development was significantly reduced, thereby facilitating strategy validation, control strategy verification, and the prediction of system performance (Kumar et al. 2022).

Single Edge Triggering Flip Flop

Single edge triggering flip-flops find extensive use in digital circuits, primarily due to their ability to synchronize signals from multiple sources arriving at different times. These flip-flops effectively mitigate the risk of data corruption or errors by ensuring that output updates occur only once per clock cycle. Their applications span various digital contexts, including clock domain crossing, data synchronization, and memory storage. Moreover, they play a crucial role in sequential logic circuits like counters, shift registers, and other setups necessitating reliable data storage and transfer.

Clocked CMOS Flip Flop

In digital systems, clocked CMOS flip-flops play a pivotal role in holding individual bits of data, primarily serving timing and synchronization functions. These flip-flops exhibit notable advantages, particularly in terms of their simplicity. Comprising just two cross-coupled inverters, their design and implementation are relatively straightforward. Furthermore, their low-power characteristics render them well-suited for scenarios demanding minimal power consumption, such as battery-operated devices or other applications with stringent power requirements.

Statistical Analysis

SPSS version 26.0, a statistical programming software, was employed for the analysis of force estimations in single-edge triggering flip-flop logic gates when compared to clocked CMOS flip-flop designs (Bauer 1986). The t-test method was utilized to generate descriptive insights, encompassing mean, standard deviation, and standard errors, for each respective model. This procedure facilitated the calculation of mean, standard deviation, and standard error values for the logic gates. In-depth analysis was conducted using an independent samples t-test, involving both the dependent and independent variables. The study outlined that the independent variables correspond to single-edge flip-flops, while the dependent variable pertains to power.

Table 1: The power value of Clocked CMOS Flip Flop and Single Edge Triggering Flip Flop.

S.NO	Group 1 Power Clocked CMOS Flip Flop	Group 2 Power Single Edge Triggering Flip Flop
1	4.98	0.50
2	4.92	0.51
3	4.88	0.53
4	4.83	0.54
5	4.77	0.54
6	4.71	0.56
7	4.68	0.58
8	4.66	0.59
9	4.62	0.59
10	4.62	0.60

Table 2: This table compares the single-edge triggering Flip Flop and Clocked CMOS Flip Flop, here the Clocked CMOS Flip Flop (4.7680) has the higher mean value when compared to the single-edge triggering Flip Flop (.5540).

Group		No. of Samples	Mean	Std. deviation	Std. mean error
Power	Clocked CMOS Flip Flop	10	4.7680	.12831	.04057
	Novel Single Edge Triggering Flip Flop	10	.5540	.03534	.01118

3 RESULTS

Table 1 displays the power values obtained from the comparison between Single Edge Triggering Flip Flop and clocked CMOS Flip Flop, considering a sample size of 10.

Table 2 presents the mean, standard deviation, and standard errors of Power Consumption for Clocked CMOS Flip Flop and Single Edge Triggering Flip Flop, respectively.

Table 3 showcases that a clocked CMOS flip flop consumes 4.7680 watts of power, while a Single Edge Triggering Flip Flop utilizes only 0.5540 watts. The results highlight a statistically significant distinction between the innovative Single Edge Triggering Flip

Flop and the double edge triggering Flip Flop ($p=0.000$), as determined by an independent sample t-test ($p < 0.05$).

Figure 1 illustrates the circuit diagram designed to detect Single Edge Triggering Flip Flops.

Figure 2 depicts the output waveform generated by a Single Edge Triggering Flip Flop.

Figure 3 provides a graphical representation comparing the power consumption of Single Edge Triggering Flip Flop and clocked CMOS Flip Flop. This graph compares the mean power values and assists in determining the more efficient power consumption.

Table 3: The Independent Sample T Test is performed. It demonstrates a statistical difference with $p=0.000$ between the innovative Single Edge Triggering Flip Flop and the double edge triggering Flip Flop (independent sample t-test $p < 0.05$).

Levene's test for equality of variances		T-test for equality of means								
		F	Sig.	t	df	Sig. (2-tailed)	Mean difference	Std. error diff.	95% confidence interval of the difference	
									lower	upper
POWER	Equal variances assumed	16.219	.001	100.132	18	.000	4.21400	.04208	4.12558	4.30242
	Equal variances not assumed			100.132	10.358	.000	4.21400	.04208	4.12067	4.30733

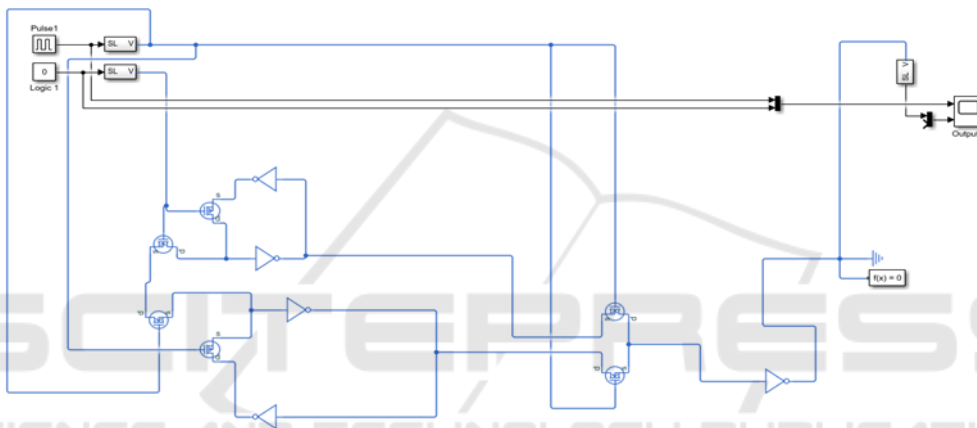


Figure 1: The schematic picture of a Flip-Flop design in which only one transistor is timed by a brief pulse train, which is known as a Single Edge Triggering Flip-Flop, is used to monitor power consumption using the MATLAB programme.



Figure 2: A novel Single Edge Triggering Flip Flop's output waveform. The output calculates the delay time and the total energy used.

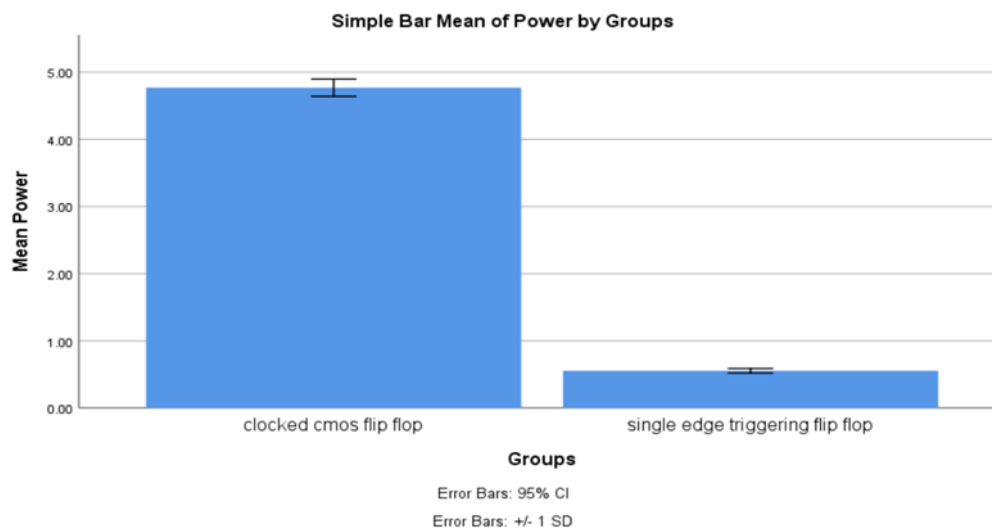


Figure 3: The bar graph shows the variation in the mean power in which it represents Clocked CMOS flip-flop and single-edge triggering flip-flop with a standard deviation of $\pm 1SD$. The x-axis represents the groups and the y-axis represents the mean power. It can be seen that a single-edge triggering flip-flop consumes less power compared to a Clocked CMOS flip-flop.

4 DISCUSSIONS

The method involves analysing the Power Consumption of a single-edge flip-flop while varying the logic gates. It was observed that the obtained value is statistically significant with a p-value of $p=0.000$. Transistors are utilized at both the latch stage and the input of the comparison preamplifier. A single local clock generator manages both phases of operation. The D FlipFlop can be understood through the use of a delay line or zero-order hold. The D input signal is captured as soon as the flip-flop is clocked, and any subsequent changes to the D input are delayed until the following clock event. This gives the D flip-flop an advantage over the D-type transparent latch in this aspect (Wenckebach and Cox 2023).

Single-edge triggering Flip Flops offer several advantages compared to Clocked CMOS Flip Flops. Firstly, they require fewer transistors and are less complex in their design. Secondly, single-edge triggering Flip Flops operate on only one clock edge, leading to a reduction in the number of clock signal transitions and subsequently lowering Power Consumption. Additionally, it's possible to design single-edge triggering Flip Flops with reduced voltage swings, contributing to lower power consumption overall (Noh et al. 2012).

However, single-edge triggering Flip Flops are vulnerable to glitches, which are unwanted pulses caused by circuit disturbances or noise. These glitches can lead to incorrect data being stored in the

flip-flop. For the future, designers can explore techniques like glitch filtering, signal conditioning, and clock gating to mitigate the impact of glitches on the input data signal and reduce the likelihood of incorrect data being stored in the flip-flop.

5 CONCLUSION

The study results indicate that Single Edge Triggering Flip Flops consume 0.5540 watts of power, whereas Clocked CMOS Flip Flops consume 4.7680 watts of power. This suggests that Single Edge Triggering Flip Flops exhibit lower Power Consumption compared to Clocked CMOS Flip Flops.

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